

# EMC TEST REPORT

<b>Project No.</b>	LBE20150046	<b>Issue No.</b>	0
<b>Applicant</b>	<b>Name of organization</b>	Samsung Electronics Co., Ltd.	
	<b>Address</b>	(Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 443-742, Republic of Korea	
	<b>Date of application</b>	January 5, 2015	
<b>EUT</b>	<b>Type of device</b>	<input checked="" type="checkbox"/> Class B personal computers and peripherals <input type="checkbox"/> All other devices	
	<b>Equipment authorization</b>	<input type="checkbox"/> Declaration of Conformity <input checked="" type="checkbox"/> Certification <input type="checkbox"/> Verification	
	<b>FCC ID</b>	A3LSMT116BU	
	<b>Kind of product</b>	Portable Device	
	<b>Model No.</b>	SM-T116BU	
	<b>Variant Model No.</b>	Refer to clause 4.6	
	<b>Manufacturer</b>	SAMSUNG ELECTRONICS VIETNAM Thai Nguyen CO., LTD KCN Yen Binh I, Pho Yen, Thai Nguyen, Vietnam	
<b>Applied Standards</b>		FCC Part 15, Subpart B, Class B / ANSI C63.4-2009	
<b>Test Period</b>		January 6, 2015 ~ January 8, 2015	
<b>Issue date</b>		January 12, 2015	

**Test result : Complied**

The equipment under test has found to be compliant with the applied standards.  
 (Refer to thtlfe attached test result for more detail.)

**Tested by** : Ho-Jin Choi



**Reviewed by** : Jong-Sup Jeong



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**CS & Environment Center of Samsung Electronics Co., Ltd.**  
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# 1. Report Information

## 1.1 Revision history

No.	Revised detailed information
Issue 0	- LBE20150046 (SAMSUNG)

# 2. Summary of test results

## 1.1 Emission

The EUT has been tested according to the following specifications:

Applied	Test type	Applied standard	Result
<input checked="" type="checkbox"/>	Conducted Disturbance (Mains port)	FCC Part 15 Subpart B / ANSI C63.4-2009 (Class B)	Complied
<input checked="" type="checkbox"/>	Radiated Disturbance		Complied

# 3. General Information

## 3.1 Test facility

The CS & Environment center is located on Samsung Electronics Co., Ltd. at (Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Republic of Korea.

All testing are performed in Semi-anechoic chambers conforming to the site attenuation characteristics defined by ANSI C63.4, CISPR 22, 16-1 and 16-2. and Shielded rooms.

The CS & Environment center is operated as testing laboratory in accordance with the requirements of ISO/IEC 17025:2005.

## 4. Test Setup configuration

### 4.1 Test Peripherals

The cables used for these peripherals are either permanently attached by the peripheral manufacturer or coupled with an assigned cable as defined below.

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Mark	Description	Model No.	Serial No.	Manufacturer / Trademark	FCC ID / DoC
A	Portable Device	SM-T116BU	-	SAMSUNG	A3LSMT116BU
B	Battery	EB-BT116ABE	-	SAMSUNG	-
C	Headset	EHS61ASFWE	-	SAMSUNG	-
D	Data Cable	ECB-DU68WE	-	SAMSUNG	-
E	micro SD Card	16GB	-	SANDISK	-
F	Desk-Top Computer	DM300S3A	-	SAMSUNG	DoC
			EBDEDC6FFD	SAMSUNG	DoC
G	LCD TV Monitor	CF19MS	CF19H1LS700048Y	SAMSUNG	DoC
		EF23TS	EM23H1LS300070L	SAMSUNG	DoC
H	Mouse	SML-210PB	TAKD125024 V	SAMSUNG	DoC
			TAKD124911 M	SAMSUNG	DoC
I	Keyboard	SDM8500P	8M001183	SAMSUNG	DoC
			8M001033	SAMSUNG	DoC
J	Gigabit Switch 8	J9794A	CN33FQ703Q	HP	DoC
			CN33FQ71XK	HP	DoC
K	Power Supply	EADP-15DC A	DIKD1245096741	Delta	DoC
			DIKD1245096576	Delta	DoC

### 4.2 EUT operating mode

To achieve compliance applied standard specification, the following mode(s) were made during compliance testing:

<b>Operating Mode 1</b>	USB Mode (Data Communication)
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### 4.3 Details of Sampling

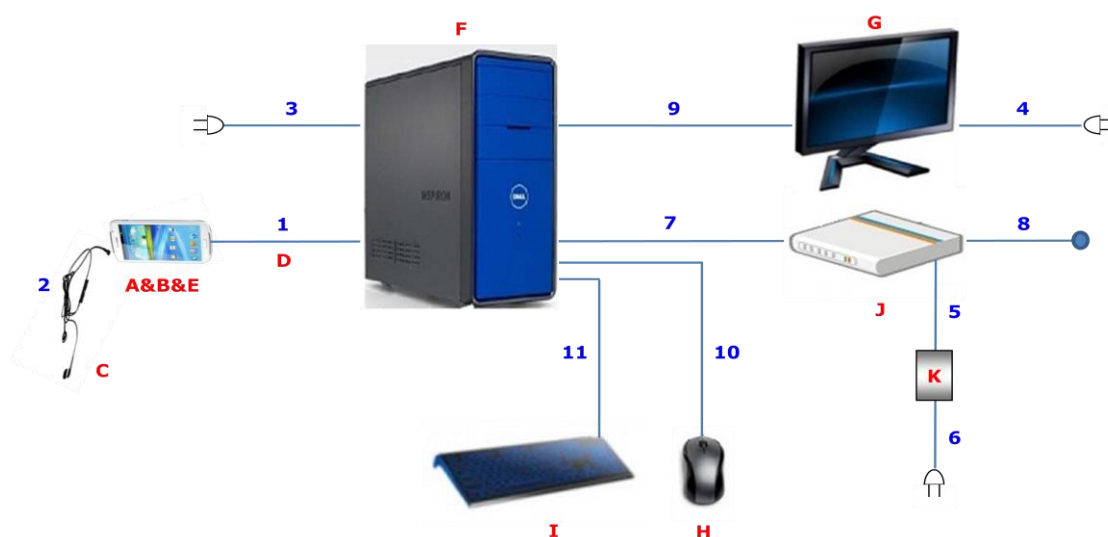
Customer selected, single unit.

## 4.4 Used cable description

The EUT is configured, installed, arranged and operated in a manner consistent with typical applications. Interface cables/loads/devices are connected to at least one of each type of interface port of the EUT, and where practical, each cable shall be terminated in a device typical of actual usage. The type(s) of interconnecting cables to be used and the interface port (of the EUT) to which these were connected:

No.	Connected cable	Length [m]	Shielded [Y/N]	Note
1	Data Cable	0.8	Yes	From EUT to PC
2	Headset	1.6	No	For EUT
3	Power	1.8	No	For Desk-Top Computer
4	Power	1.8	No	For LCD TV Monitor
5	Power	1.8	No	From Gigabit Switch 8 to Power Supply
6	Power	1.8	No	For Power Supply
7	LAN	1.5	No	From Desk-Top Computer to Gigabit Switch 8
8	LAN	1.5	No	From Gigabit Switch 8 to Local Area Network
9	RGB	1.8	Yes	From Desk-Top Computer to LCD TV Monitor
10	PS/2	1.5	Yes	From Desk-Top Computer to Mouse
11	PS/2	1.5	Yes	From Desk-Top Computer to Keyboard

## 4.5 Test arrangement



## 4.6 EUT Description

4.6.1 The following features describe EUT represented by this report:

Item	Specification	
Frequency Range	GSM 850 WCDMA B5	TX : 824.2 ~ 848.8 MHz RX : 869.2 ~ 893.8 MHz
	GSM 1900 WCDMA B2	TX : 1 850.2 ~ 1 909.8 MHz RX : 1 930.2 ~ 1 989.8 MHz
Operating Temperature (°C)	+5 ~ +35	
Operating Humidity (%)	0 ~ 95	

4.6.2 The variant models

- None

## 4.7 Clock Frequencies

Kind of Clocks	Frequency [ MHz ]	Kind of Clocks	Frequency [ MHz ]
CPU	1 200	-	-

## 4.8 Test configuration and condition

- The EUT exercise program which is the Samsung standardized emission test program for Windows was used during all EMC measurements were tested. This program was contained on the PC hard disk drive. Once loaded, the program sequentially exercises each system component in turn.
- The EUT was exercised during the testing by data read and write cycles repeated with internal storage devices. At the end of the test, the copied back data was compared with original.
- The EUT was connected to the PC by using USB data cable to charge.
- The system was configured for testing in a typical fashion that a customer would normally use, and was tested while in an automated non-attendant mode.

Power source for the EUT operating was supplied by CVCF made by the Pacific Power Source Corp.

**- Test Voltage : AC 120 V, 60 Hz**

## 4.9 Measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus: (According to CISPR 16-4 and UKAS Lab 34.)

### 4.9.1 Emission

Test type		Measurement uncertainty (C.L. 95 %, k = 2)
Conducted disturbance	AC Mains	2.78 dB
Radiated Disturbance (30 MHz ~ 1 GHz)	Horizontal	4.02 dB
	Vertical	4.05 dB
Radiated Disturbance (1 GHz ~ 6 GHz)	Horizontal	4.35 dB
	Vertical	4.35 dB

## 5. Results of individual test

### 5.1 Conducted disturbance

The EUT was connected to the Desk-Top Computer which was powered from one LISN for the measurements. The support equipment power cables were connected to a second LISN.

Both conducted lines are measured in Quasi-Peak and Average mode, including the worst-case data points for each tested configuration. The EUT measured in accordance with the methods described in standards.

#### Limits for conducted disturbance at the mains ports of Class B ITE

Frequency range Limits [ MHz ]	Resolution Bandwidth [ kHz ]	Limits [ dB(μV) ]	
		Quasi-peak	Average
0,15 to 0,50	9	66 to 56	56 to 46
0,50 to 5	9	56	46
5 to 30	9	60	50

NOTE 1 The lower limit shall apply at the transition frequency.  
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

#### 5.1.1 Test instrumentation

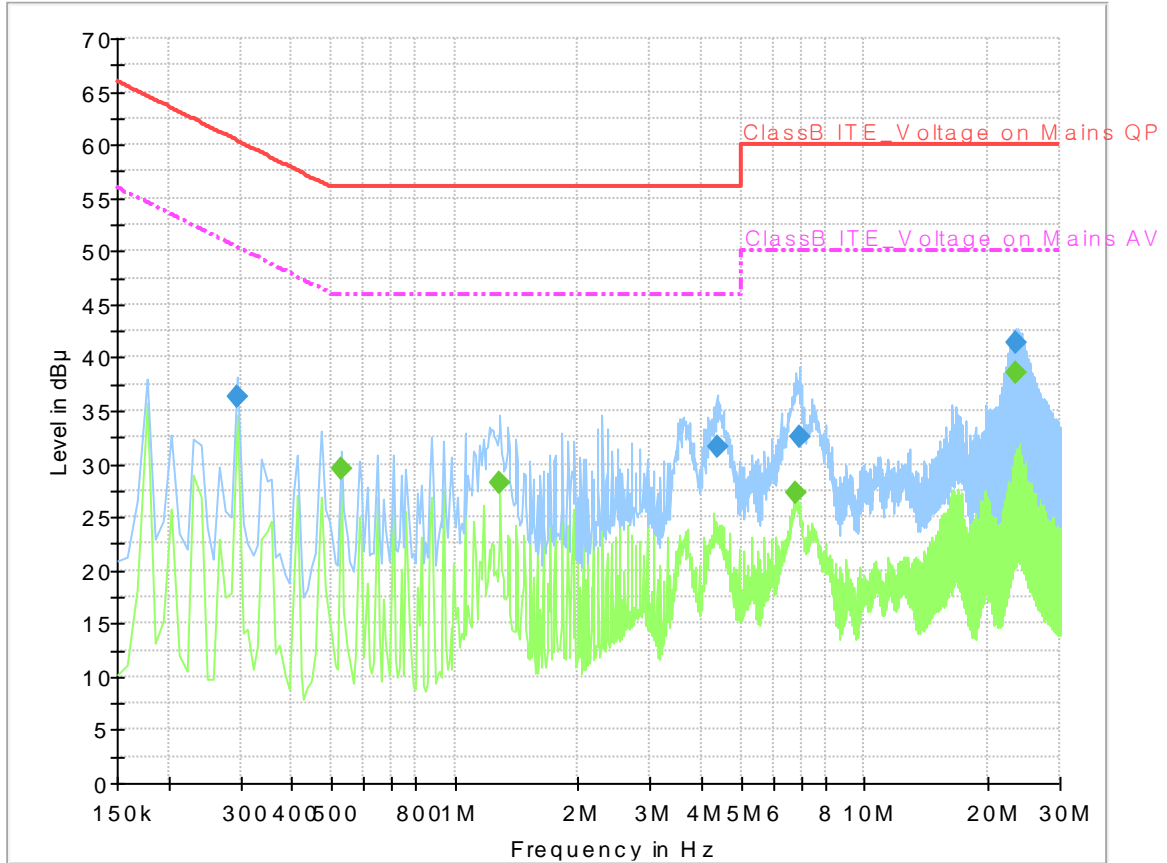
EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-010	LISN	ESH3-Z5	R&S	100263	2014-10-29	12
E5I-018	EMI Test Receiver	ESU8	R&S	100484	2014-06-03	12
E5I-043	LISN	ENV216	R&S	101630	2014-06-02	12

#### 5.1.2 Temperature and humidity condition

<b>Test date</b>	2015-1-8	<b>Test engineer</b>	Ho-Jin Choi
<b>Climate condition</b>	Ambient temperature	(23.5~ 23.7) °C	Limit (15.0 to 35.0) °C
	Relative humidity	(44.6~ 44.8) % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	(102.0 ~ 102.2) kPa	Limit (86.0 to 106.0) kPa
<b>Test place</b>	Shield Room (SR14)		

### 5.1.3 Test results

#### □ Operating Mode 1: AC Mains



Note 1) Two graphs measured for both Live(L1) and Neutral(N) of the LISN are combined into one graph.

Final measurement results table (QP/CAV):

Frequency (MHz)	QP Level (dBµV)	CAV Level (dBµV)	Limit (dBµV)	Margin (dB)	Line	Corr. (dB)
0.294	36.2	---	60.4	24.2	N	9.9
0.528	---	29.6	46.0	16.4	N	9.9
1.293	---	28.3	46.0	17.7	N	9.7
4.362	31.6	---	56.0	24.4	N	9.7
6.819	---	27.2	50.0	22.8	N	9.7
6.927	32.6	---	60.0	27.4	N	9.7
23.397	41.4	---	60.0	18.6	N	10.0
23.514	---	38.5	50.0	11.5	L1	9.9

Note 2) Level (QP and/or CAV) = Meter Reading (QP and/or CAV) + Corr. (LISN Insertion Loss + Cable Loss)

Margin (QP and/or CAV) = Limit – Level (QP and/or CAV)

QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor

## 5.2 Radiated disturbance

The following data lists the significant emission frequencies, measured levels, correction factors (for antenna and cables), orientation of table, polarization and height of antenna, the corrected reading, the limit, and the amount of margin.

Peak measurements were made over the changeable frequency range 30 MHz to 1 GHz at a measurement distance of 10 m for the following antenna and turntable arrangements:

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ kHz ]	Video Bandwidth [ kHz ]	Turntable position [ degrees ]
100 ~ 400	Horizontal, Vertical	120	300	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using quasi-peak detector.

Peak/CISPR-Average measurements were made over the changeable frequency range 1 GHz to 40 GHz or 5th harmonics of the highest frequency in accordance with internal maximum operating frequency at a measurement distance of 3 m for the following antenna and turntable arrangements

Antenna Height [ cm ]	Antenna Polarisation	Resolution Bandwidth [ MHz ]	Video Bandwidth [ MHz ]	Turntable position [ degrees ]
100 ~ 400	Horizontal, Vertical	1	3	0 ~ 345 (Step size: 15 degrees)

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using peak and CISPR-average detectors.

### Limits for radiated disturbance of Class B ITE at a measuring distance of 3 m and 10 m

Frequency range Limits [ MHz ]	Field Strength		
	3 m [ $\mu\text{V/m}$ ]	3 m [ dB( $\mu\text{V/m}$ ) ]	10 m [ dB( $\mu\text{V/m}$ ) ]
30 to 88	100	40.0	29.5
88 to 216	150	43.5	33.0
216 to 960	200	46.0	35.5
Above 960	500	54.0	43.5

Results checked manually; and points close to the limit line were re-measured.

## 5.2.1 Test instrumentation

EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-015	EMI Test Receiver	ESU8	R&S	100481	2014-06-02	12
E5I-020	EMI Test Receiver	ESU40	R&S	100375	2014-06-09	12
E5I-036	Double-Ridged Waveguide Horn Antenna	HF907	R&S	100507	2013-04-02	24
E5I-072	BiLog Antenna	CBL6112D	TESEQ	36009	2013-06-03	24
E5I-071	BiLog Antenna	CBL6112D	TESEQ	35384	2013-05-23	24
E5I-093	Preamplifier	310N	Sonoma	273122	2014-01-13	12
E5I-094	Preamplifier	310N	Sonoma	282363	2014-01-13	12

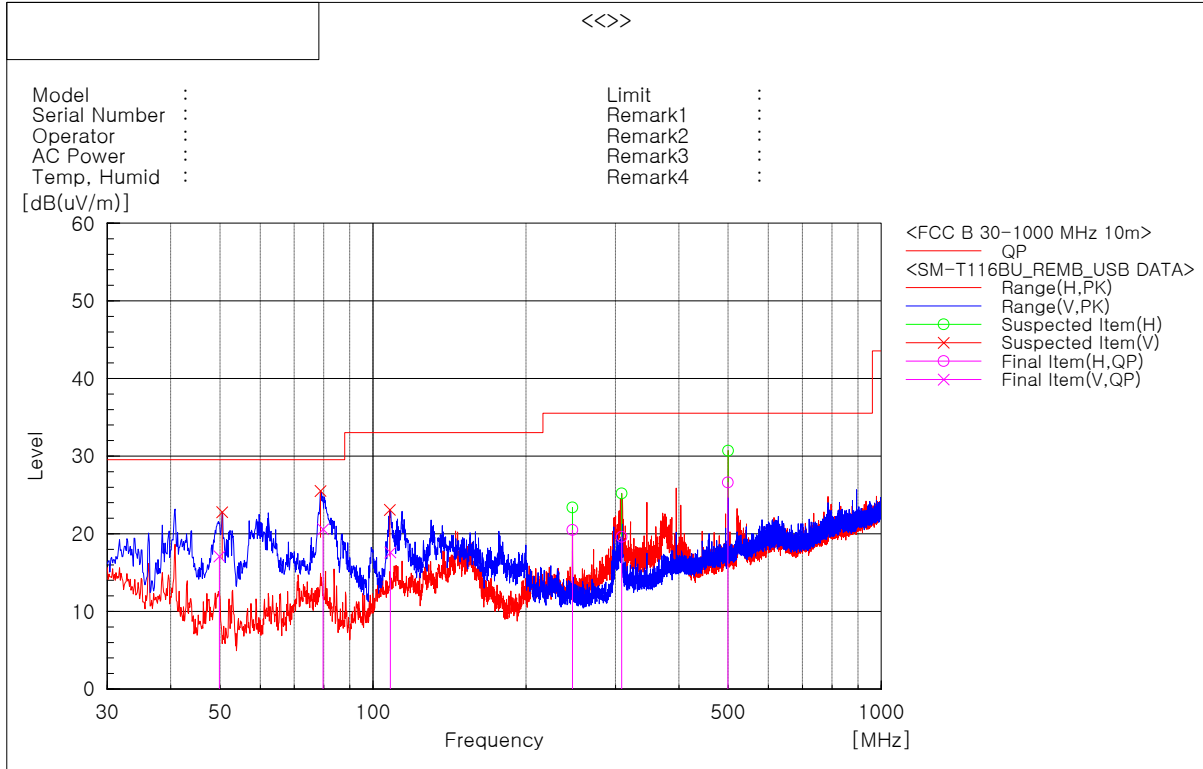
## 5.2.2 Temperature and humidity condition

<b>Test date</b>	2015-1-6	<b>Test engineer</b>	Ho-Jin Choi
<b>Climate condition</b>	Ambient temperature	(23.5~ 23.7) °C	Limit (15.0 to 35.0) °C
	Relative humidity	(47.4~ 47.6) % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	(102.3 ~ 102.5) kPa	Limit (86.0 to 106.0) kPa
<b>Test place</b>	Semi-Anechoic Chamber (SAC8)		

### 5.2.3 Test results

Operating Mode 1

- Frequency range below 1GHz



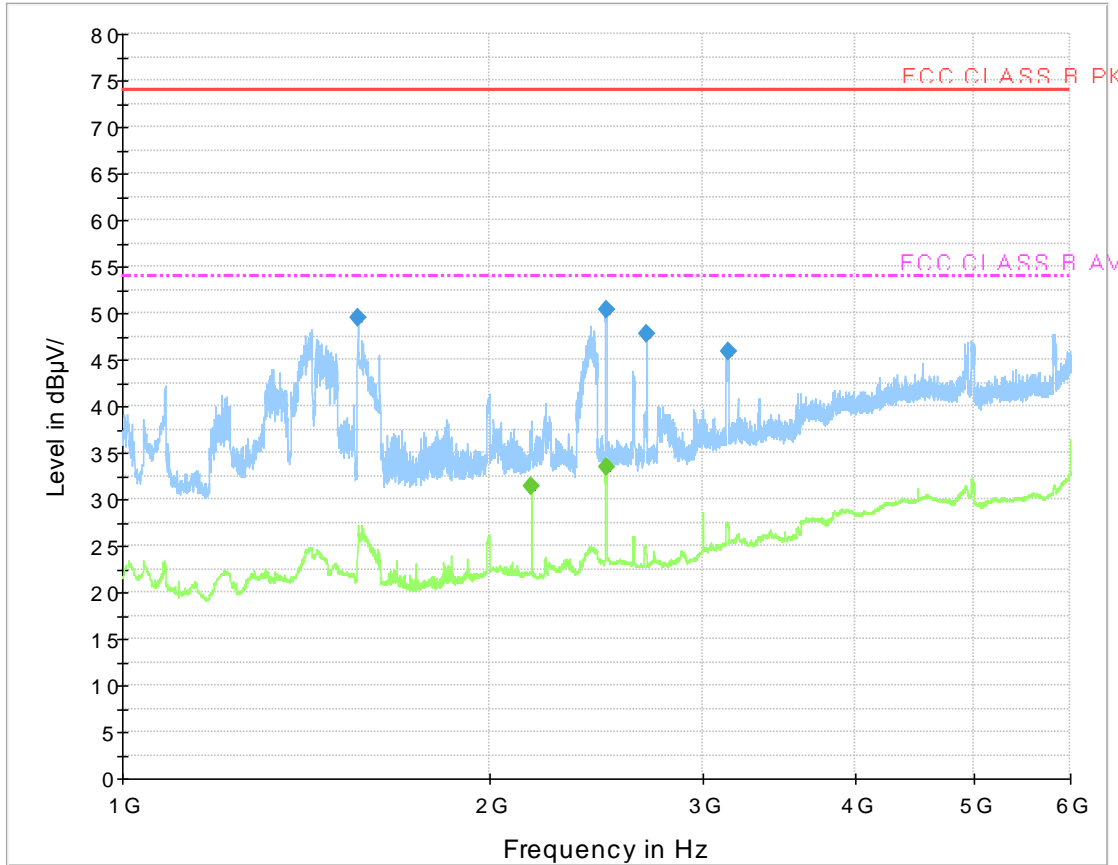
Final Result

--- Horizontal Polarization (QP)---										
No.	Frequency [MHz]	Reading [dB(uV)]	c.f [dB(1/m)]	Result [dB(uV/m)]	Limit [dB(uV/m)]	Margin [dB]	Height [cm]	Angle [deg]	System	
1	246.898	38.3	-17.8	20.5	35.5	15.0	281	183	1	
2	308.347	35.4	-15.8	19.6	35.5	15.9	298	172	1	
3	499.229	38.8	-12.2	26.6	35.5	8.9	183	26	1	
--- Vertical Polarization (QP)---										
No.	Frequency [MHz]	Reading [dB(uV)]	c.f [dB(1/m)]	Result [dB(uV/m)]	Limit [dB(uV/m)]	Margin [dB]	Height [cm]	Angle [deg]	System	
1	49.841	39.7	-22.6	17.1	29.5	12.4	116	216	2	
2	79.782	43.7	-23.1	20.6	29.5	8.9	184	52	2	
3	108.161	35.7	-18.1	17.6	33.0	15.4	176	86	2	

Note) Receiving antenna polarization : Horizontal, Vertical  
 Test Distance : 10 m, Antenna Height : 1 to 4 meters  
 Level (QP) = Reading (QP) + c.f (Antenna Factor + Cable Loss - Amp. Gain)  
 Margin (QP) = Limit - Level (QP)  
 QP = Quasi-Peak, c.f = Correction Factor

Operating Mode 1

- Frequency range above 1GHz



MEASUREMENT RESULT (PK/CAV):

Frequency (MHz)	PK Level (dBµV)	CAV Level (dBµV)	Limit (dBµV)	Margin (dB)	Height	Pol	Azimuth	Corr (dB)
1 560.500	49.5	---	74.0	24.5	100.0	V	180.0	-6.2
2 169.000	---	31.4	54.0	22.6	100.0	V	0.0	-2.7
2 494.500	---	33.4	54.0	20.6	100.0	H	180.0	-0.9
2 496.000	50.3	---	74.0	23.7	100.0	H	180.0	-0.8
2 691.500	47.7	---	74.0	26.3	100.0	H	0.0	0.1
3 141.500	45.8	---	74.0	28.2	100.0	H	180.0	3.2

Note) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 3 m, Antenna Height : 1 to 4 meters

Level (PK and/or CAV) = Reading (PK and/or CAV) + Corr. (Antenna Factor + Cable Loss - Amp. Gain)

Margin (PK and/or CAV) = Limit – Level (PK and/or CAV)

PK = Peak, CAV = CISPR-Average, Corr. = Correction Factor